Intermodulation distortion in wide-band dual-mode bulk ferroelectric bandpass filters

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Intermodulation Distortion in Wide-Band Dual-Mode Bulk Ferroelectric Bandpass Filters

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Abstract — An investigation into intermodulation (IM) distortion in bulk ferroelectric bandpass filters is presented. The main objective has been to study the effect of the response time of ferroelectric material on IM distortion. In order to investigate the response time IM measurements with wide carrier frequency spacing must be performed. Thus a novel planar dual-mode bandpass filter, with 600MHz bandwidth at 2GHz, has been designed and fabricated on a bulk Barium Strontium Titanate (BST) substrate. The two tone third-order IM has been measured for a range of signal separations in order to estimate the material response time.

Index Terms — Disc resonator, dual-mode filter, ferroelectric material, intermodulation distortion, response time.

I. INTRODUCTION

Tuneable microwave filters are very desirable components for multi-band mobile handsets. Several classes of tuneable microwave bandpass filters have been reported. These include varactor tuned filters [1] active varactor tuneable filters [2], and MESFET varactor tuned filters [3]. A fundamental problem with varactor diodes is that they respond almost instantaneously to the applied voltage. Thus not only the dc bias voltage but also the RF signal voltage will modulate the filter response, giving rise to IM distortion.

Bulk and thin-film ferroelectric materials exhibit a variation in bulk dielectric permittivity ($\varepsilon_r$) with applied electric field. Thus these are potentially extremely useful materials for implementing tuneable microwave devices such as integrated filters, phase shifters etc [4]. However, there is no detailed information available in the literature on the response time of bulk materials, although some data on thin-film materials has been reported [5].

One of the most popular tuneable materials is the paraelectric phase composition of Barium Strontium Titanate (Ba\(_{1-x}\)Sr\(_x\)TiO\(_3\)) or BST with $x=0.4-0.6$. The paraelectric-ferroelectric transition temperature (Curie temperature) and the electrical properties of BST can be tailored for various device applications by varying the concentration of strontium. For microwave integrated circuit applications the field dependent permittivity and the dielectric loss at high frequency need to be low and the permittivity should exhibit with high tuneability at room temperature. So, various compositions of pure BST as well as composites of BST with different non-ferroelectric oxides have been studied by the authors [6]. However, this paper presents realisation of microwave integrated filters using these materials rather than concentrating on material research.

Initially a narrowband, bandwidth~3MHz at centre frequency 155MHz, microstrip combline filter using bulk BST capacitor was constructed, to study the material tuneability and to model the material non-linearity by performing IM distortion measurements [7]. The measured in-band third-order intercept point resulting from signals 1MHz apart was +38dBm.

The main aim was to investigate the response time of the permittivity change due to change in applied electric field. This can be approximately evaluated by applying a range of two tone test signals with variable separation. If the IM product power levels reduce as the signal separation is increased then this can be attributed to the material response time. To perform accurate measurements the bandwidth of the filter must be at least as large as the signal separation. The combline filter approach using bulk ferroelectric capacitors is not at all suitable for wide bandwidth designs because the high permittivity of the material produces high capacitance values.

Fig. 1. Hyeteresis curves of relative permittivity as a function of dc bias for pure BST ($\varepsilon_r\sim4000$).

Fig. 2. Hysteresis curve of relative permittivity as a function of dc bias for 0.4BST+0.6MgO ($\varepsilon_r\sim750$) (courtesy Filtronic Comtek).
Alternatively a wide-band two-pole dual-mode integrated bandpass filter with a passband bandwidth of 600MHz at a centre frequency of 2GHz on a bulk BST substrate has been designed. The measured in-band IM performance of the filter indicates that the response time of the material $\tau \leq 20$ns.

Two different compositions of BST have been used as bulk ferroelectric substrates for microfabrication of the integrated filters; one was pure BST for $x=0.4$ with $\varepsilon_r \sim 4000$, loss tangent $\tan \delta \sim 0.0009$ and tuneability 1.38% at 50kV/mm (Fig. 1) and the other was 0.4BST+0.6Magnesium Oxide (MgO) with $\varepsilon_r \sim 750$ at 6.7GHz, $\tan \delta \sim 0.017$ and tuneability 1.02% at 10kV/mm (Fig. 2), all are at room temperature.

II. MICROSTRIP COMBLINE TUNEABLE BANDPASS FILTER

A single section microstrip combline filter, shown in Fig. 3, was designed on duroid substrate. A block of BST ($\varepsilon_r \sim 4000$) about 2mm thick, electroded with silver was used as a bulk capacitor loading the resonator line of the filter. The bulk parallel plate capacitor response as a function of dc bias voltage is shown in Fig. 4. For the purposes of simulation the CV curve was fitted with a second order polynomial.

The variation of the centre frequency of the filter as a function of dc voltage is shown in Fig. 5. The small difference in resonant frequency between the measured and simulated results is due to some stray capacitance introduced in the hardware. Several hundreds of volts/mm is required to achieve significant tuneability for bulk ferroelectric capacitors, so only 0.24% per 100Volts filter tuneability has been achieved. Fig. 6 shows measured frequency response of the filter.

III. INTERMODULATION DISTORTION

When multiple input signals are applied to a nonlinear circuit, IM products will appear in the output spectrum. The most significant of these are the two tone third-order products which can appear in-band. Measured and simulated results of two tone in-band third-order products in terms of third-order intercept point of the filter have been plotted in Fig. 7. Third-order intercept point is defined as $IP_3 = (3P_{in} - P_3)/2$, where $P_{in}$ is the input signal power and $P_3$ is the power of the output third-order IM product. The measured $IP_3$ was $\sim +38$dBm for input signals separated by 1MHz. The two tone third-order IM performance of the circuit was simulated using the harmonic balance solver in ADS (Advance Design System). This gave a check on the measurement procedure, as IM measurements are not trivial.

The $IP_3$ remain more or less constant with applied bias field because extremely high voltages are required to tune the bulk capacitor. Furthermore, it was not possible to evaluate the IM performance of this filter with widely separated tones as its bandwidth was only 3MHz. The design of a wide-band filter for this purpose is described in the next section.
IV. WIDE-BAND DUAL-MODE MICROSTRIP BANDPASS FILTER - DESIGN AND FABRICATION

A wide-band dual-mode microstrip disc resonator bandpass filter has been designed on bulk ferroelectric substrate, with 2GHz centre frequency and a 20dB return loss with bandwidth 600MHz. The concept of realising bandpass filter by using the two degenerate modes of a disc resonator was reported in [8]. Two orthogonal degenerate modes can be excited in the microstrip disc by taking the electrical length of the periphery equal to the guided wavelength. These two modes can be interpreted as two travelling waves: one travelling clockwise and the other anti-clockwise. By introducing some perturbation, for example, a notch along the periphery (thus introducing a path difference between the two waves) these two modes can be split or can be coupled. Increasing the coupling between these two modes widens the bandwidth of the filter.

![Optical microscopic image of the circuit fabricated on BST (εr~4000), input/output line coupling gap 2µm.](image)

Fig. 8. Optical microscopic image of the circuit fabricated on BST (ε_r~4000), input/output line coupling gap 2µm.

The first attempt at a two-pole filter design is shown in Fig. 8. Because of very high permittivity (ε_r~4000) of the substrate material the capacitive coupling gaps of the input/output lines could not be modelled accurately using commercial electromagnetic software. An alternative direct-coupled design was employed, Fig. 9. In this case the strength of the coupling can be adjusted by feeding the input closer to the centre of a disc resonator, where the field is weaker.

![Filter circuit on the test fixture, inset: enlarged microscopic image of the integrated filter on BST (ε_r~750).](image)

Fig. 9. Filter circuit on the test fixture, inset: enlarged microscopic image of the integrated filter on BST (ε_r~750).

Microfabrication of this circuit on bulk ceramic has been done successfully developing a new fabrication recipe for this new substrate [9]. The high dielectric constant of BST reduces the circuit dimensions to tens of microns. We have used a medium resolution 10kV electron beam lithography machine to pattern the circuit. Poor electrical conductivity of the ferroelectric substrate makes it inappropriate for direct exposure under electron beam, so a 20nm metal (Aluminium) layer was evaporated on the substrate. Chemically amplified resist, UV-III, has been used and it has reduced the writing time significantly. Development was carried out using CD-26. The pattern was then transferred to the underlying ferroelectric substrate by evaporating 20nm of Chrome and 120nm of Gold, followed by a subsequent lifting off.

V. WIDE-BAND FILTER FREQUENCY RESPONSE AND IM STUDY

Modelling of the second type of filter was performed using advance electromagnetic simulator ADS-Momentum. Circuits were fabricated successfully on both BST ceramics with ε_r~4000 and with ε_r~750. However, modelling on BST with ε_r~4000 was not very successful due to the high value of permittivity. The measured and simulated frequency responses of the second direct-coupled filter on BST with ε_r~750 are shown in Fig. 10. Here the simulation includes estimates of dielectric loss and conductor losses.

![Bandpass filter frequency response (BST, ε_r~750); solid curves for simulation and dashed curves for measured results.](image)

Fig. 10. Bandpass filter frequency response (BST, ε_r~750); solid curves for simulation and dashed curves for measured results.

The measured frequency response shows reasonable agreement with theoretical predictions, particularly in terms of centre frequency, mid-band insertion loss and low frequency response. There is a significant difference between the passband bandwidths of the simulated and measured responses, with the measured 3dB bandwidth being 740 MHz. This is believed to be associated with the practical test fixture, where spurious couplings between the input and output probes have a significant effect on the location of the finite transmission zero on the high side of the passband. Also the selectivity of the filter is poor on the low frequency side of the passband. This is entirely due to the direct path from input to output and could be improved by increasing the degree of the filter. Finally the mid-band insertion loss of 0dB is a little high for most applications, this is mainly associated with the conductor losses.

For two tone third-order IM measurements of the filter, generation of two relatively pure RF signals at high enough power (~25dBm) is difficult because of amplifier non-linearities. The block diagram for IM measurement is shown in Fig. 11. Two tones generated from the signal synthesiser are amplified to equal power levels of 25dBm. These were then passed through two separate transmission channels TX1 and TX2 of a diplexer and were fed into the DUT. The output from
the DUT was input to a second diplexer to collect the third-order IM term in the TX filter, the RX filter was terminated in a high power load. The IM was passed through another narrowband RX filter to remove any unwanted frequencies prior to the spectrum analyser. All the TX and the RX filters in the diplexers are designed very carefully to stop any spurious signals from reaching the spectrum analyser.

![Block diagram for 3rd order IM measurement of the filter.](image)

The IP$_3$ of two tone third-order IM are plotted in Fig. 12. The IP$_3$ for tone separations of 46.6MHz and 33.4MHz were similar +74dBm, however as the signal separation was increased to 80MHz IP$_3$ rises to +77.5dBm, corresponding output third-order product power level dropped from -73dBm to -80dBm. It is reasonable to conclude from these measurements that the response time of the dielectric (time taken to reach 50% of its value) was in the region of 10-20ns. Note that no attempt was made to include the time-constant of the IM filter circuit was successfully micro-fabricated using electron beam lithography and state-of-the-art pattern transfer techniques. The filter frequency response and two tone IM measurements have been presented. The results for output third-order power indicate the material response time to be between 10 and 20ns. The filter IM performance would thus be better than achievable using semiconductor varactors which respond much faster.

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